

DOSEMI**IGBT****DG160X07TDSM****650V/160A IGBT with Diode****General Description**

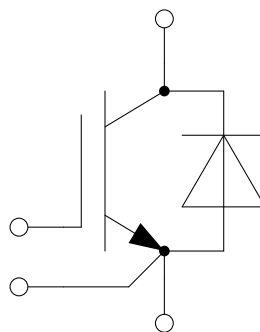
DOSEMI IGBT Power Discrete provides ultra low conduction loss as well as low switching loss. They are designed for the applications such as general inverters and UPS.

Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- Maximum junction temperature 175°C
- $V_{CE(sat)}$ with positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD

Typical Applications

- Inverter for motor drive
- AC and DC servo drive amplifier
- Uninterruptible power supply

Equivalent Circuit Schematic

Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage Transient Gate-Emitter Voltage	± 20 -25/+30	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=100^{\circ}\text{C}$	200 ⁽¹⁾ 160	A
I_{CM}	Pulsed Collector Current t_p limited by T_{vjmax}	480	A
P_D	Maximum Power Dissipation @ $T_{vj}=175^{\circ}\text{C}$	1079	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	650	V
I_F	Diode Continuous Forward Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=90^{\circ}\text{C}$	200 ⁽¹⁾ 160	A
I_{FM}	Diode Maximum Forward Current t_p limited by T_{vjmax}	480	A

Discrete

Symbol	Description	Values	Unit
T_{vjop}	Operating Junction Temperature	-40 to +175	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
T_S	Soldering Temperature, 1.6mm from case for 10s	260	$^{\circ}\text{C}$

(1) limited by bondwire

IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=160\text{A}, V_{GE}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		1.55	2.00	V
		$I_C=160\text{A}, V_{GE}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		1.80		
		$I_C=160\text{A}, V_{GE}=15\text{V}, T_{vj}=175^{\circ}\text{C}$		1.90		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=2.56\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^{\circ}\text{C}$	5.0	5.8	6.5	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			200	μA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			100	nA
R_{Gint}	Internal Gate Resistance			0		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		17.2		nF
C_{oes}	Output Capacitance			0.79		nF
C_{res}	Reverse Transfer Capacitance			0.47		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.89		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=4.7\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=25^{\circ}\text{C}$		58		ns
t_r	Rise Time			49		ns
$t_{d(off)}$	Turn-Off Delay Time			190		ns
t_f	Fall Time			89		ns
E_{on}	Turn-On Switching Loss			3.82		mJ
E_{off}	Turn-Off Switching Loss			3.93		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=4.7\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=150^{\circ}\text{C}$		62		ns
t_r	Rise Time			51		ns
$t_{d(off)}$	Turn-Off Delay Time			212		ns
t_f	Fall Time			123		ns
E_{on}	Turn-On Switching Loss			4.91		mJ
E_{off}	Turn-Off Switching Loss			4.92		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=4.7\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=175^{\circ}\text{C}$		63		ns
t_r	Rise Time			53		ns
$t_{d(off)}$	Turn-Off Delay Time			216		ns
t_f	Fall Time			129		ns
E_{on}	Turn-On Switching Loss			5.28		mJ
E_{off}	Turn-Off Switching Loss			5.08		mJ
I_{SC}	SC Data	$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_{vj}=150^{\circ}\text{C}, V_{CC}=400\text{V}, V_{CEM} \leq 650\text{V}$		800		A

Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=160\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.70	2.15	V
		$I_F=160\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.65		
		$I_F=160\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.65		
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}, I_F=160\text{A},$ $-di/dt=3240\text{A}/\mu\text{s}, L_S=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=25^\circ\text{C}$		60		ns
Q_r	Recovered Charge			3.59		μC
I_{RM}	Peak Reverse Recovery Current			87		A
E_{rec}	Reverse Recovery Energy			0.77		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}, I_F=160\text{A},$ $-di/dt=2880\text{A}/\mu\text{s}, L_S=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=150^\circ\text{C}$		118		ns
Q_r	Recovered Charge			7.39		μC
I_{RM}	Peak Reverse Recovery Current			102		A
E_{rec}	Reverse Recovery Energy			1.84		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}, I_F=160\text{A},$ $-di/dt=2900\text{A}/\mu\text{s}, L_S=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=175^\circ\text{C}$		127		ns
Q_r	Recovered Charge			8.84		μC
I_{RM}	Peak Reverse Recovery Current			108		A
E_{rec}	Reverse Recovery Energy			2.27		mJ

Discrete Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per IGBT)			0.139	K/W
	Junction-to-Case (per Diode)			0.252	
R_{thJA}	Junction-to-Ambient		40		K/W

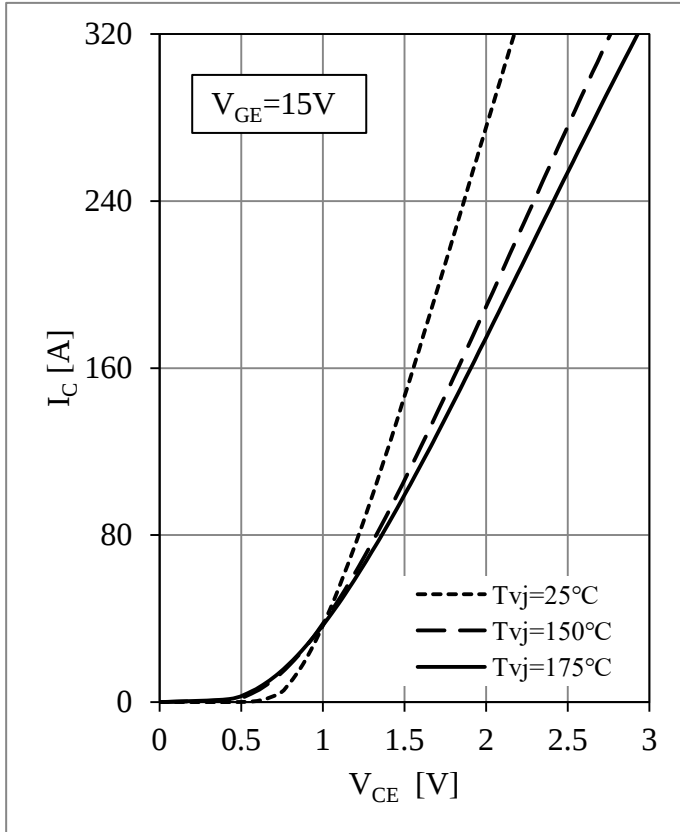


Fig 1. IGBT-inverter Output Characteristics

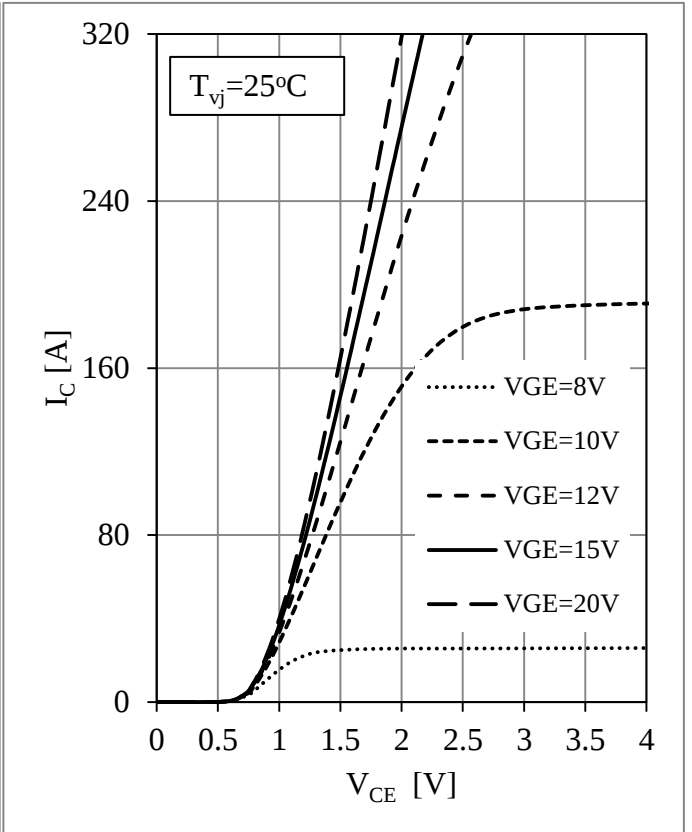


Fig 2. IGBT Output Characteristics

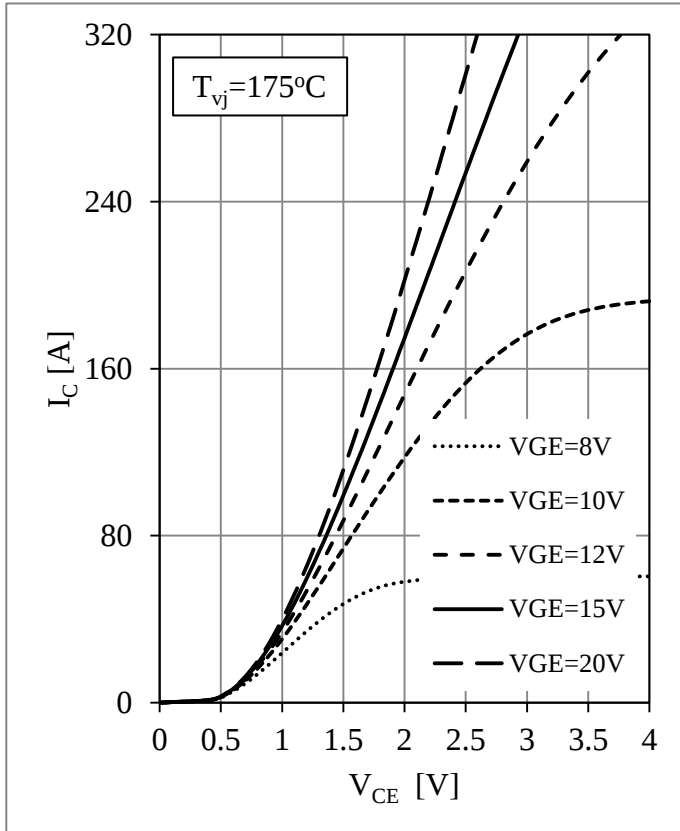


Fig 3. IGBT Output Characteristics

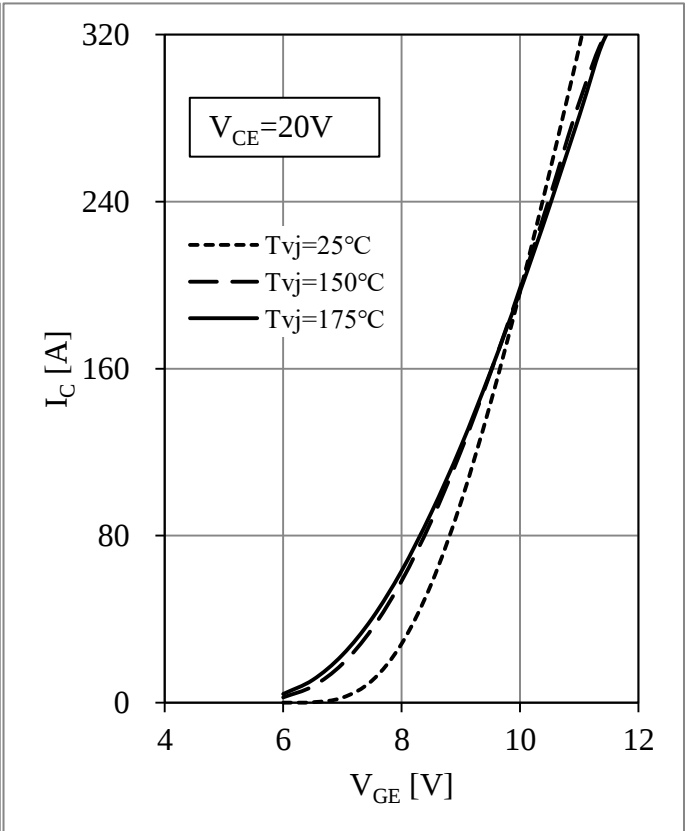
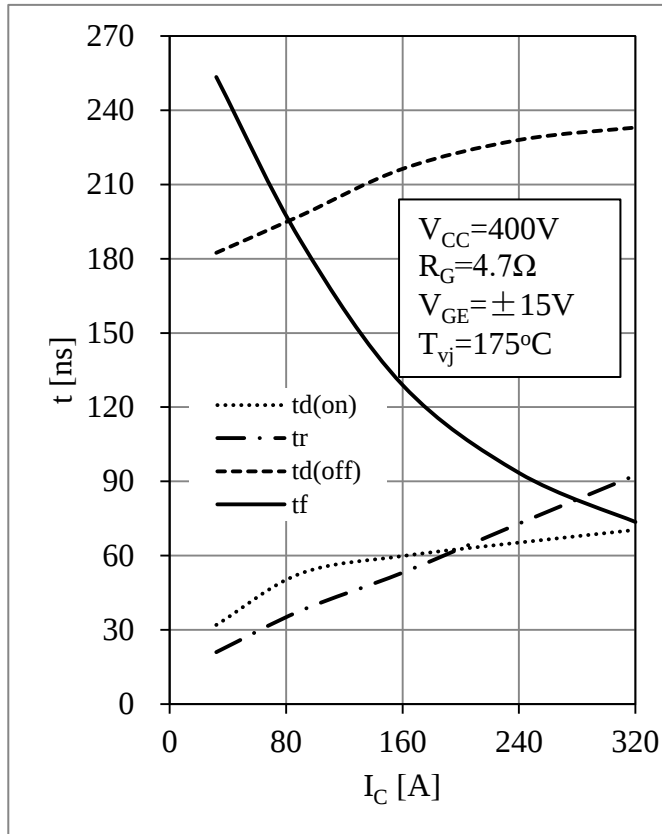
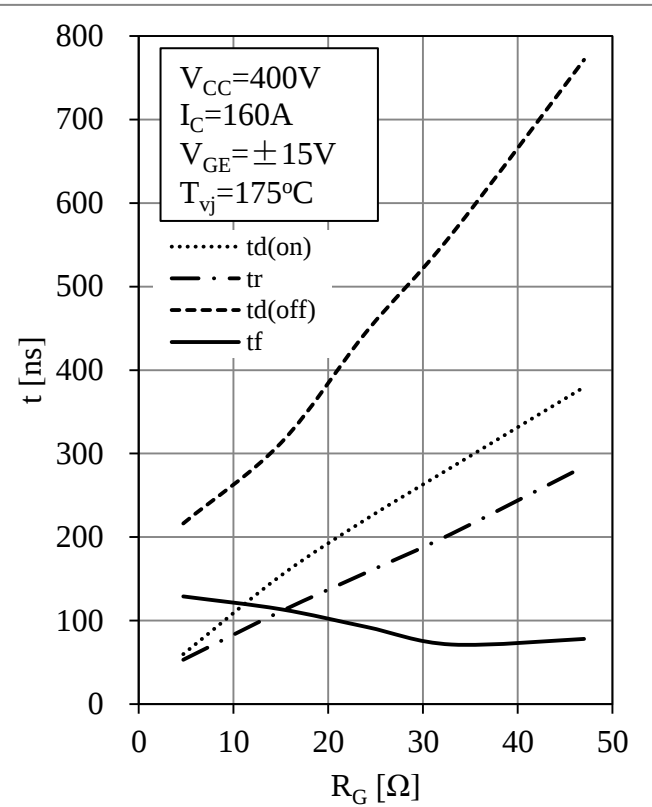
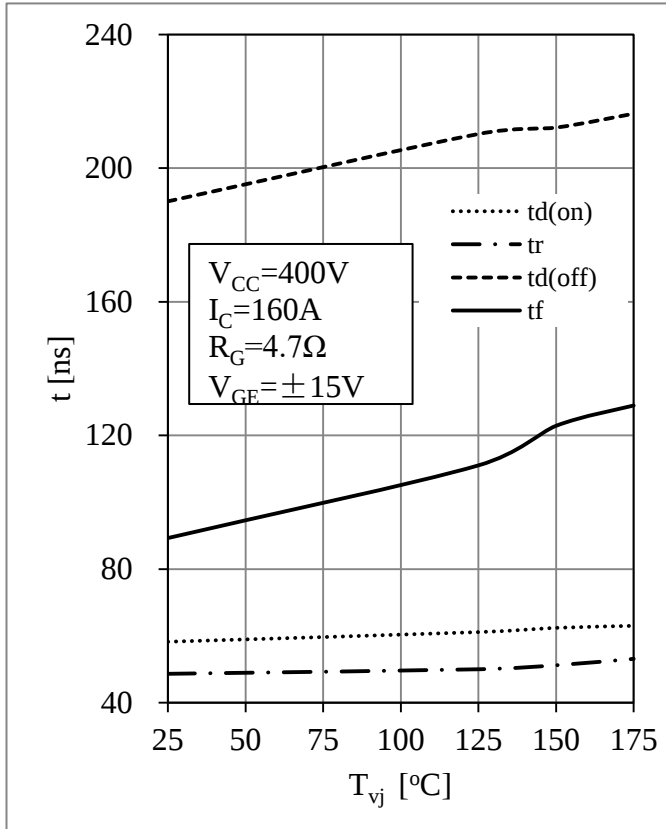
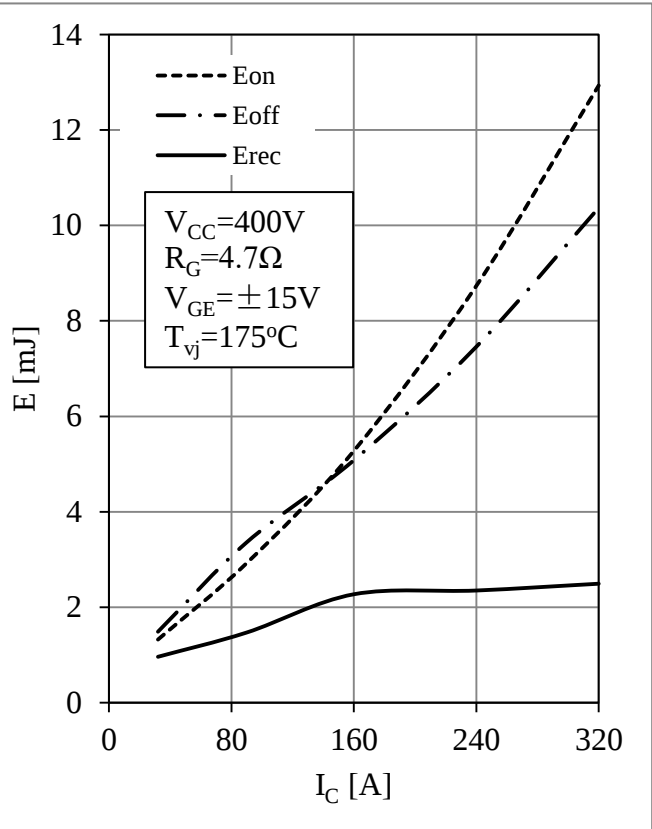


Fig 4. IGBT Transfer Characteristics

Fig 5. IGBT Switching Times as. I_C Fig 6. IGBT Switching Times as. R_G Fig 7. IGBT Switching Times vs. T_{vj} Fig 8. Switching Energy Loss vs. I_C

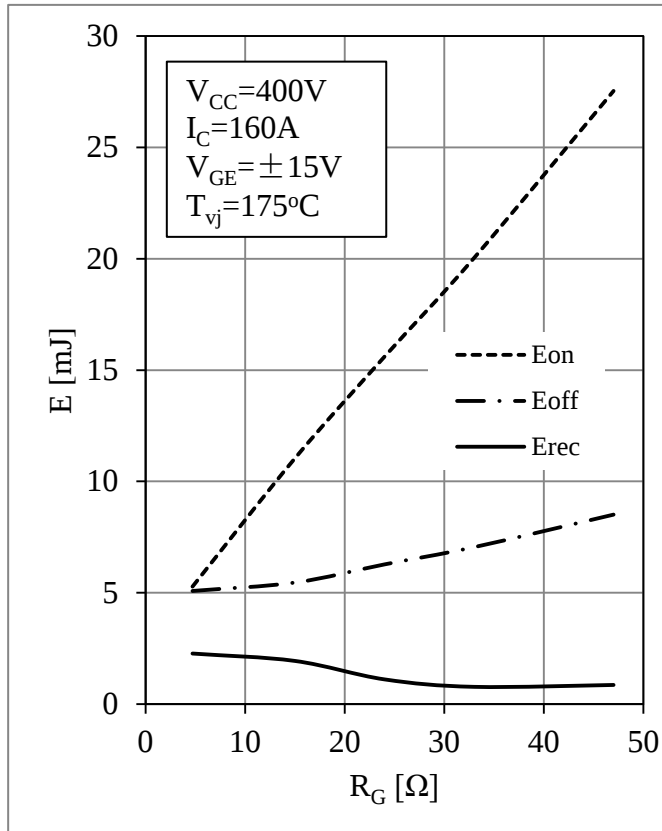
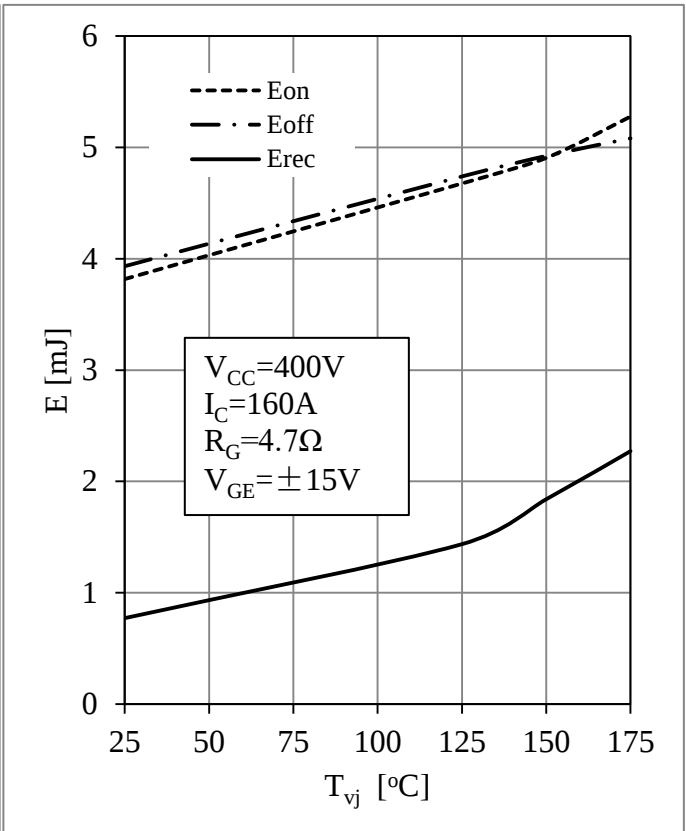
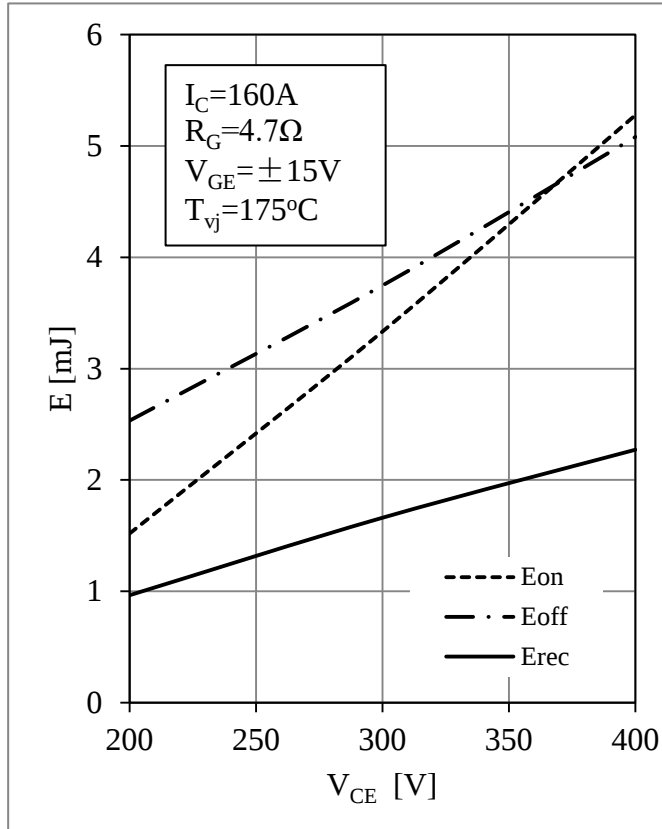
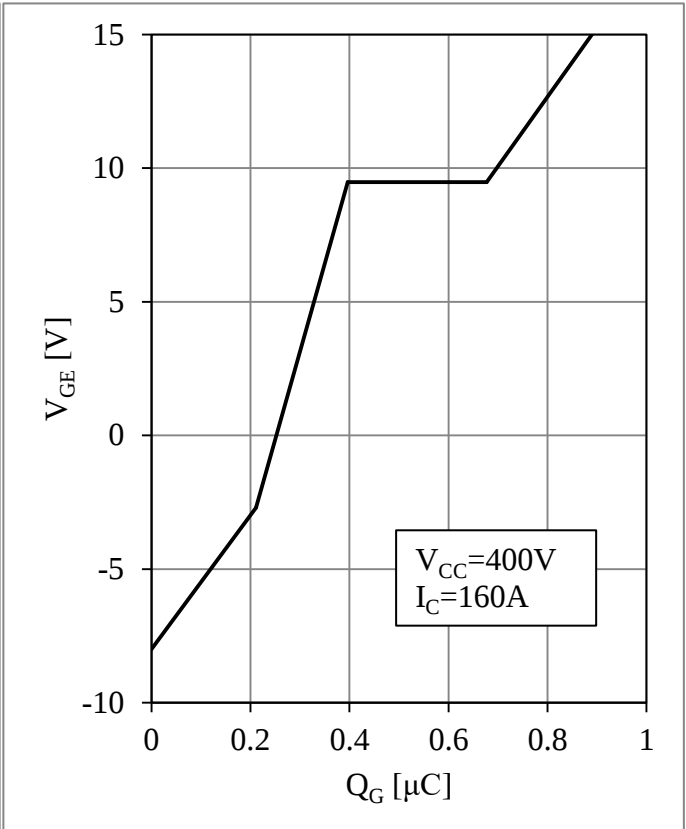
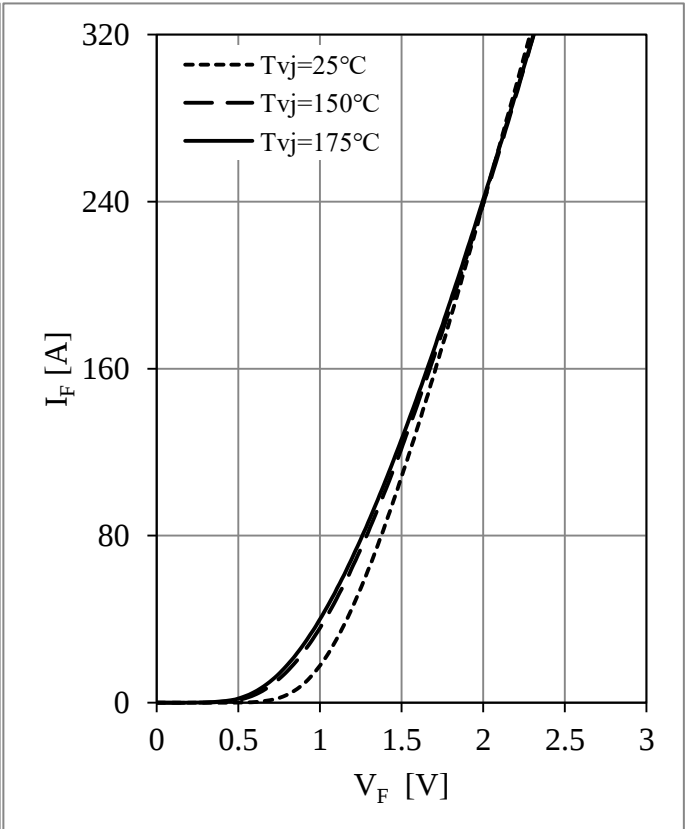
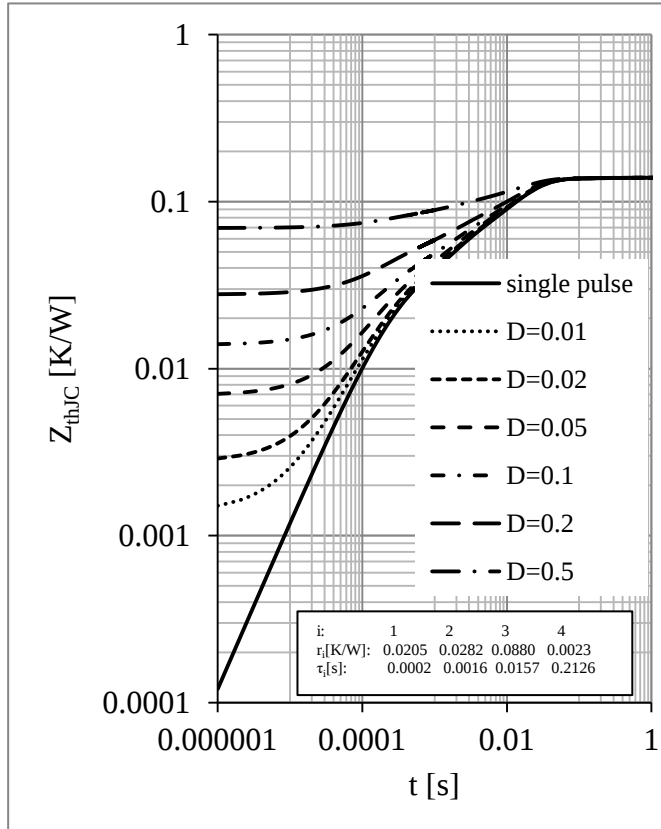
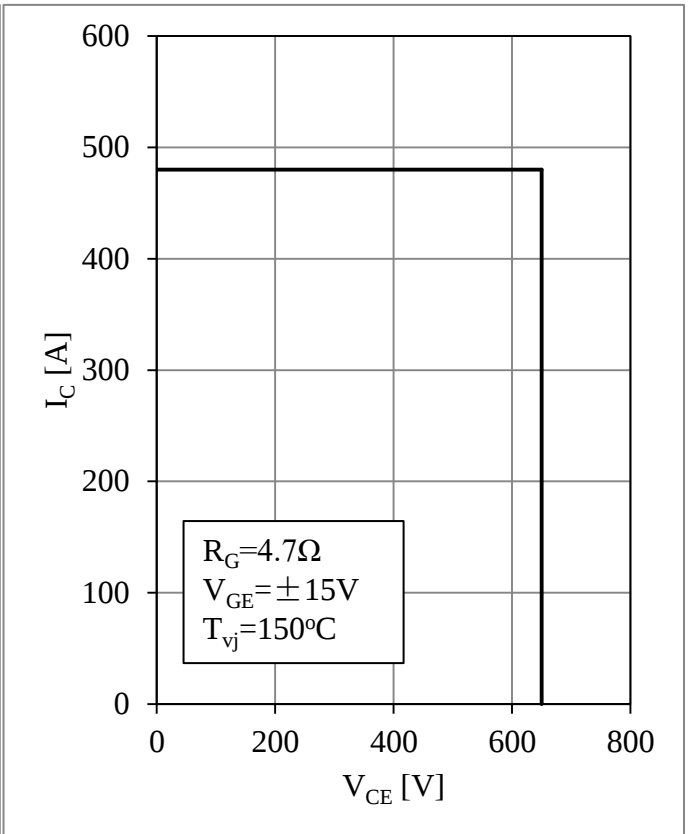
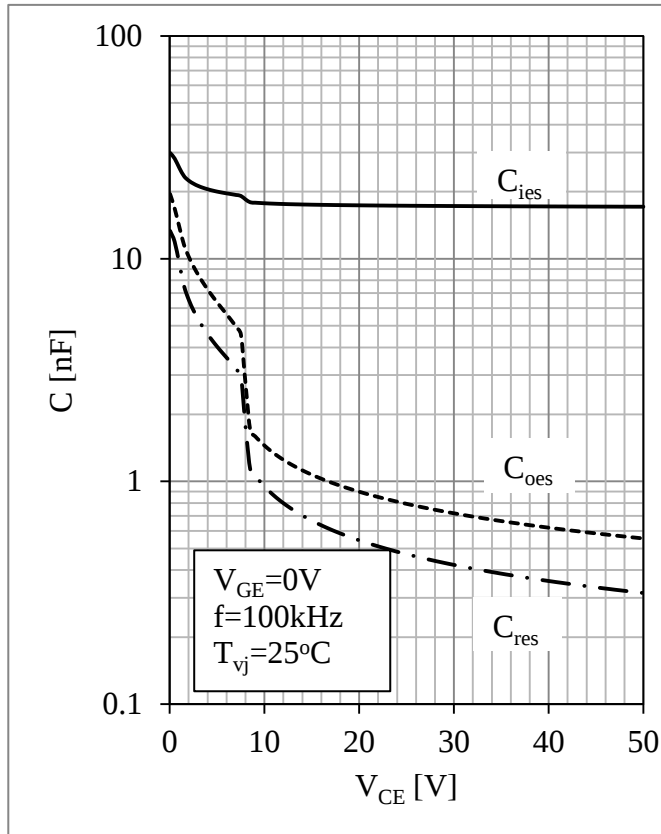
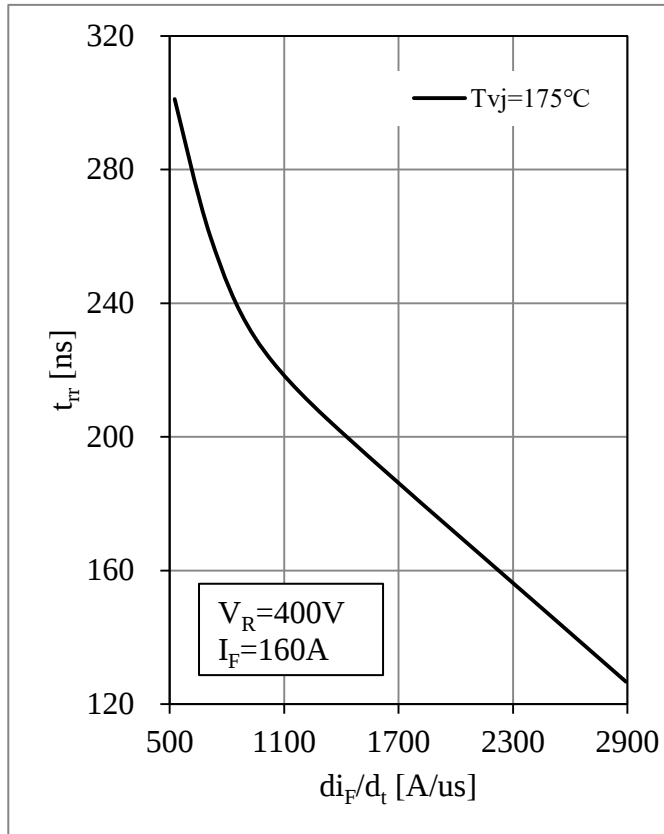
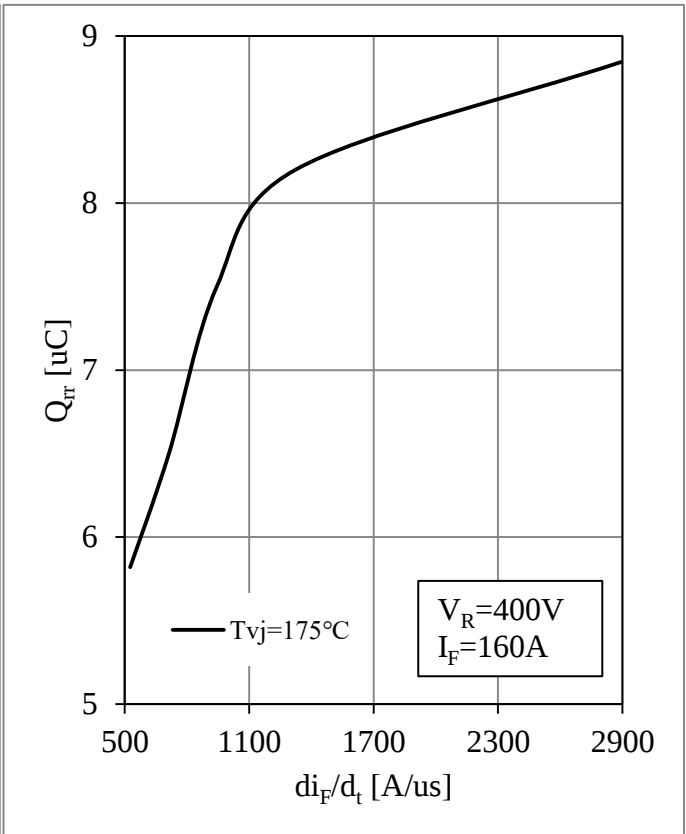
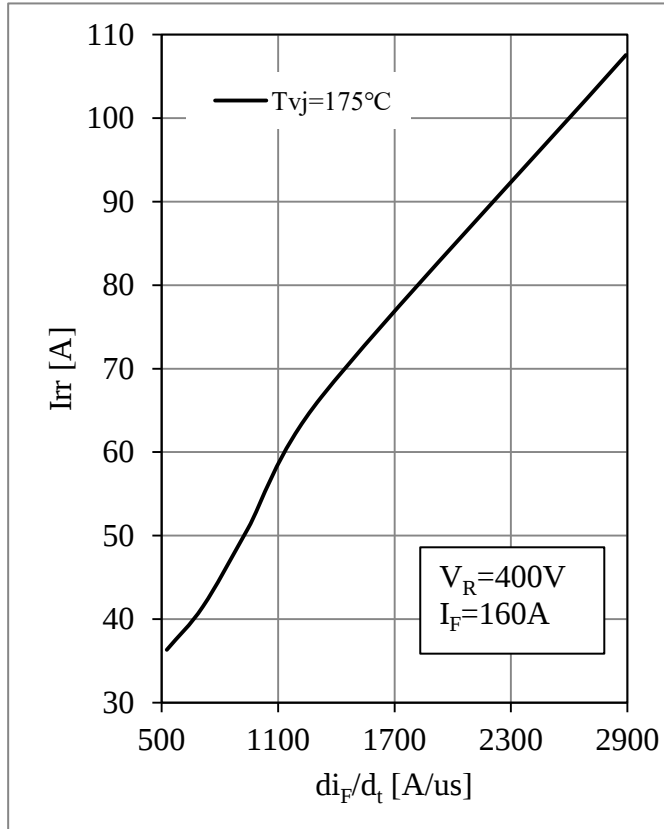
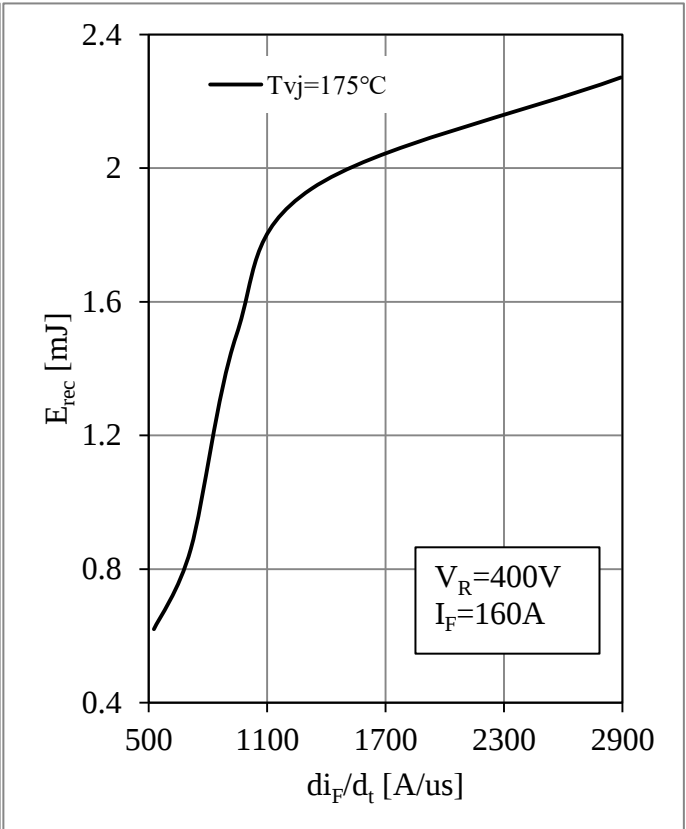
Fig 9. Switching Energy Loss vs. R_G Fig 10. Switching Energy Loss vs. T_{vj} Fig 11. Switching Energy Loss vs. V_{CE} 

Fig 12. IGBT Gate Charge Characteristic



Fig 17. Reverse Recovery Time vs. di_F/d_t Fig 18. Reverse Recovery Charge vs. di_F/d_t Fig 19. Reverse Recovery Current vs. di_F/d_t Fig 20. Reverse Energy Losses vs. di_F/d_t

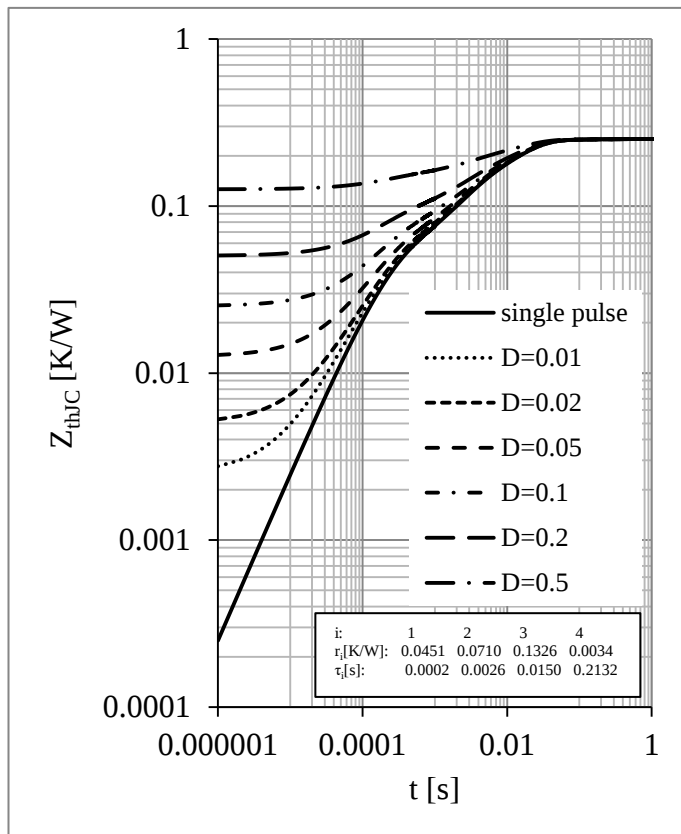
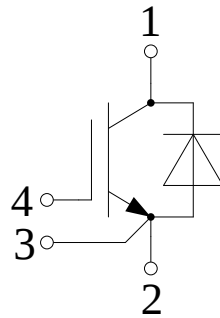


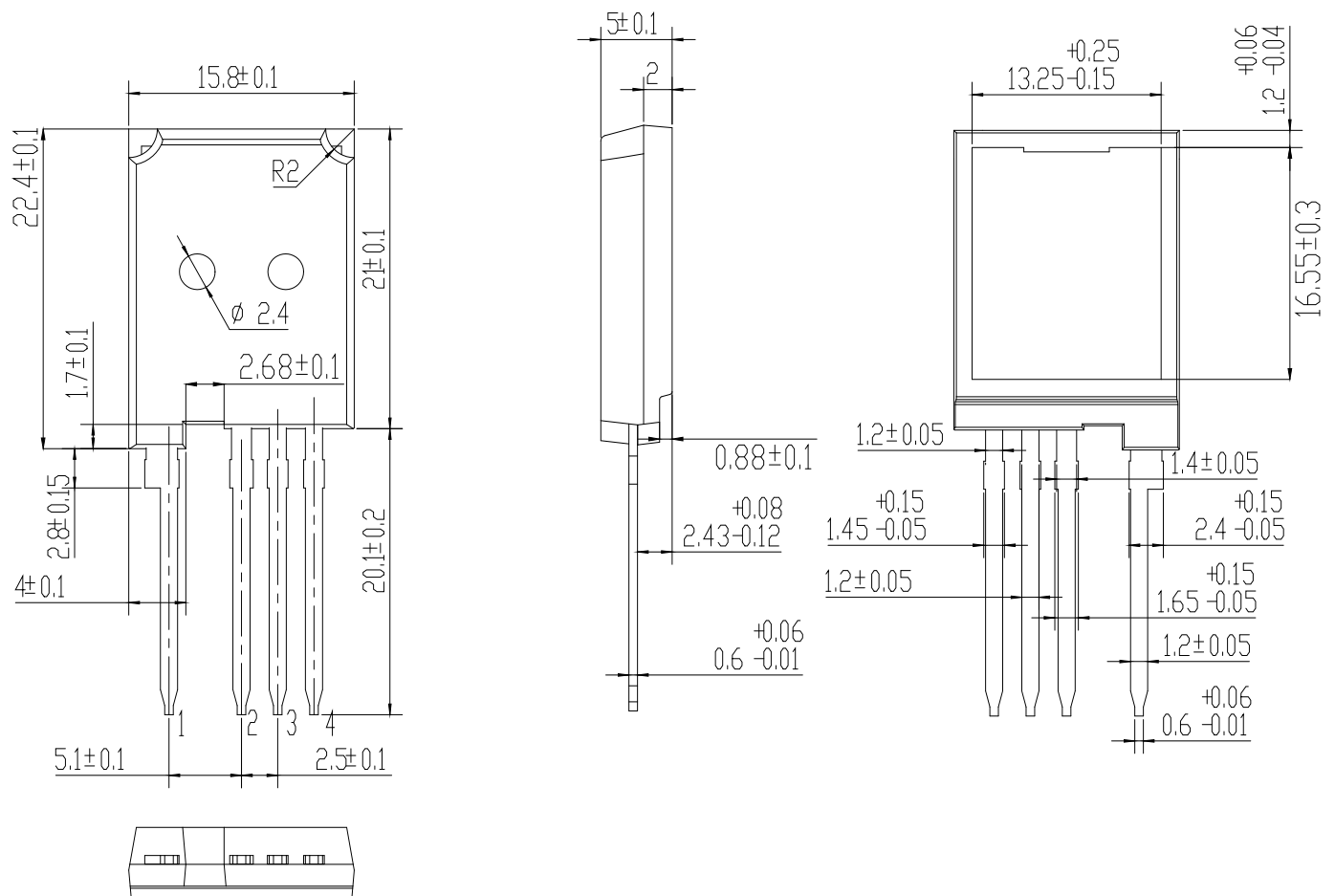
Fig 21. Diode Transient Thermal Impedance

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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